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54 **Metal coated laminate products made from textured polyimide film.**

57 A process for coating at least one surface of a polyimide sheet with copper in the absence of an adhesive, initially comprises hydrophilizing the surfaces of the polyimide with a caustic solution, then contacting said sheet with a catalyst to create surfaces receptive to electroless deposition of nickel or cobalt. After depositing nickel or cobalt coatings which are electrically conductive, microcracks are formed in said coatings, and said polyimide sheet coated with nickel or cobalt containing microcracks is heated to volatilize components in said polyimide sheet. Subsequently copper is deposited on said nickel surface or cobalt surface by electrolytic deposition to form exposed copper coatings on said polyimide sheet. The layers of the resulting laminate are tenaciously bonded, exceeding current standard bond strength requirements for materials to be used in electronic circuitry.

**EP 0 329 406 A1**

## Description

## METAL COATED LAMINATE PRODUCTS MADE FROM TEXTURED POLYIMIDE FILM

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BACKGROUND OF THE INVENTION

This invention relates to a process for coating one or both surfaces of a polyimide sheet with electrolessly deposited nickel or cobalt and electrolytically deposited copper, and to the thermally stable laminate product obtained by the process.

10 Certain electronic assemblies have conductor traces on both sides of a dielectric substrate. Preferred dielectrics for applications requiring flexible substrates, especially in multilayer constructions, involve the use of polyimide films. In general practice the conductive layers on this substrate are provided through the use of metal foils and adhesives specially formulated for their physical and thermal stability. The conductive layers are also provided in some cases through direct metalization by sputtering or by electroless deposition involving

15 methods well known to those versed in the art. Currently there are no commercially available polyimide laminate materials produced in the absence of an adhesive, suitable for IPC Class 3 electronic circuit applications. The adhesive bonding method has certain disadvantages especially in critical service and multilayer applications, where either properties of the adhesive or the physical space occupied by the adhesive are limiting factors. For example, these adhesive-bonded laminate materials exhibit poor dimensional stability, a severe disadvantage for laying up multilayer boards. The preferred construction (especially in multilayer applications) would avoid the use of adhesives and provide the metal directly bonded to the substrate. Until the present invention, however, the methods available for direct metalization of polyimide film substrates had more significant drawbacks than the adhesive bonding methods.

20 Two methods for preparing polyimide adhesiveless metal coated laminates are the related methods of vacuum and sputter deposition, followed by electrolytic copper buildup to desired thicknesses. Sputtering provides better adhesion than vapor deposition but neither technique provides physical properties adequate for critical service applications. Several commercially available single-sided materials are produced by these methods. The adhesion values obtained on subsequent copper buildup to greater than 25  $\mu\text{m}$  are very low for materials with sputtered copper. One structure has an initial chromium layer sputtered to the polyimide film which is then covered with a sputtered layer of copper. A disadvantage of this construction is that chromium is not removed easily during subtractive processing of electronic traces using standard etchants designed to remove copper.

25 An alternative method for preparing a polyimide adhesiveless metal clad laminate is to cast a liquid solution of a polyamic acid onto the surface of a metal foil, and to heat the entire composition to a temperature which will imidize the polyamic acid and form a polyimide or amide modified polyimide film. Several modifications of this basic technique are disclosed in U.S. Patents 3,682,960; 3,781,596; 3,981,691; 4,148,969; 4,496,794 and 4,675,246. At present, laminates produced by this technique have limited application areas due to their poor dimensional stability. This method is also limited by the availability of suitable foil thicknesses.

30 In order to provide an adherent metal layer or layers to a polyimide film substrate by chemical metal deposition, several basic procedures are employed. Since processing is done in aqueous solutions, the surface of the polyimide film must be rendered hydrophilic to facilitate uniform adsorption of the catalyst used for seeding the electroless metal deposition. Commonly referred to as etching, this treatment also serves to microetch the surface of the polyimide, thus providing a mechanical interlock between the polyimide and metal layer. This surface preparative step will be referred to herein as texturing for purposes of this application to avoid confusion with the removal of unwanted metal during circuit preparation which also is referred to as etching in the printed circuit industry.

35 U.S. Patents 3,791,848 and 3,821,016 to DeAngelo disclose an aqueous ethylenediamine composition wherein the diamine is present in an amount in excess of its degree of solubility, thereby forming a two-phase system. The preferred aqueous basic compounds are disclosed as the hydroxides of the alkali metals including sodium, potassium, lithium, rubidium, and cesium. The examples are specifically directed to texturing with sodium hydroxide in very strong solution containing the ethylenediamine in suspension so as to yield a pitted surface on the polyimide. Since a two-phase system is utilized, the polyimide surface tends to be non-uniformly and incompletely textured. The degree of texturing for a given portion of the surface depends upon which phase of the solution to which a portion of the surface is primarily exposed. These non-uniformities result in subsequent non-uniform deposition of catalyst and electroless metal and in a rough irregular appearance of the final metal coated film, and variable bond strengths of subsequently deposited metal layers.

40 U.S. Patent 4,517,254 to Grapentin et al claims the use of various metal chelators primarily EDTA (ethylenediamine tetracetate) derivatives, and NTA (nitrilo triacetic acid) in dilute caustic solutions as treating agents to prepare polyimide thin films for metalization. Grapentin suggests a long list of many possible amine compounds which could be combined in mixtures containing caustic, but no specific examples are provided other than the above, to determine which mixtures would provide benefit, and to what extent. It is known from DeAngelo that one could combine amines with caustic to affect the polyamide surface, but Grapentin provides no peel strength data, or description of the surface topography of his treated films.

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Grapentin does not describe the problem or propose a solution to treatment of film by two phase mixtures. The Grapentin patent therefore does not address the subject of a uniformly and completely textured surface and does not clearly identify that his process does indeed provide a useable laminate material for class three circuit application.

U.S. Patent 3,767,538 to Politycki et al describes an attempt to produce a well-adherent double-sided laminate on polyimide film. The film surface is roughened by a fresh mixture of sulfuric and hydrochloric acids or by mechanical impingement of sand on the surface and, if needed, a further sodium hydroxide treatment may be employed. The polyimide film is then heated to expel water and then seeded for metalization in a colloidal palladium bath. After this, an electrically conductive, water-vapor permeable continuous layer of silver is deposited by electroless deposition and the film is heated at 150°C to expel water. Finally, a layer of copper is electrolytically deposited to form the laminate structure. No specific adhesion values are reported for the laminate produced by this method.

A high speed additive circuit process on a polyimide substrate using electroless nickel for metalization (no etching of metal required) is described in U.S. Patent 3,573,973 to Drotar et al. The basic process steps are: preparing the substrate, catalyzing, printing a mask, heat setting of the masking ink, electroless plating of a nickel/phosphorous alloy, heating at 195°C to improve metal to polyimide bond and then either electrolytic plating or solder coating to decrease the electrical resistance of the resultant structure. The use of a nickel/phosphorous alloy as the metalizing layer may cause difficulty etching laminates produced by this method during subtractive circuit production methods. The adhesion values reported are 5.0 lb./in. maximum by a nonstandard test and there is no mention of the stability of the product to solder float or thermal cycling stress. The low adhesion of metal to polyimide limits the use of these laminates to specialty applications. The method of Drotar, therefore, does not provide a method for preparation of metal coated laminates for general use in the printed circuit industry.

In U.S. Patent 3,954,570 to Shirk et al, another additive method is disclosed wherein the electroless deposit may be nickel or another metal. The authors cite no advantage of one metal over another in the initial metalizing step, and specifically claims a patterned flame sensitized surface which is catalyzed, preferably with tin and palladium, then electroless plated with either copper, nickel, or cobalt. The method of Shirk also provides low bond strengths, and for the nonstandard solder dip test disclosed, no advantage is recognized for the use of electroless nickel rather than electroless copper or cobalt.

Another additive method for circuit preparation on a polyimide substrate is disclosed in U.S. Patent 4,078,096 to Redmond et al. The method described is for texturing the surface of the polymer with a hydrazine/caustic solution, catalyzing, then plating with either electroless nickel, copper or cobalt. The method relates to the preparation of a specific circuit type by an additive process, and the maximum initial peel strength disclosed is only 4.6 lb./in. which is too low for general use in the printed circuit industry. Samples made by the method of this patent result in cohesive failure of the polyimide film at bond values of only 4.0 lb./in. using the optimum formulation of 60 percent hydrazine hydrate and 9.3 percent sodium hydroxide disclosed by Redmond in Table II. This lowering of the cohesive strength of the film is alluded to by Redmond in Column 4, lines 37-40, where the failure mode of well adhered and poorly adhered samples is discussed. Cohesive failure at such low values indicates degradation of the polymer film which is seen as ripping in the Z-axis during peel testing. There is no disclosure of completely coating one or both surfaces of a polyimide sheet with electrolessly deposited metal followed by electrolytically deposited metal.

There have been prior attempts to provide an adherent metal layer on both sides of polyimide sheets by direct metalization using electroless copper followed by electrolytic copper buildup to the desired thickness. This technique has proven unsuitable in practice since blistering of the electroless copper layer usually occurs when simultaneously applied to both sides of the film. If blistering is avoided, the peel strength of the resultant laminate is less than that for a single-sided laminate of the same metal thickness.

Perrins, in Transactions of the Institute of Metal Finishing (1972) Volume 50, pp. 38-45, discloses a process for electroplating propylene polymers with electroless nickel or copper followed by electrolytic plating with copper. The plating in this case is conducted on only one side of propylene copolymer plaques. The use of the nickel provides improved adhesion especially after thermal cycling of the sample which will cause degradation of the copper/polymer bond. This process, where nickel is used as the base metal layer, has only been applied to injection molded or bulk processed polymers, but has not been extended for use on thin film substrates. Therefore, the nickel process has been restricted to use where the nickel layer is never removed but remains a permanent part of the finished article.

In "Applications of Additive Circuitry", a technical paper presented at the Institute of Printed Circuits in September, 1974, Brewer discloses a method in which nickel is deposited on both surfaces of a paper reinforced phenolic. Electroless copper is then deposited and the plated panel is heated beyond the glass transition temperature of the substrate material to improve the nickel to polymer adhesion.

In Plating and Surface Finishing, "Interfacial Bonding of Nickel to Polyamide-Imide", Vol.66, No. 6, (June, 1979) pp.68-71, Levey et al, describes nickel plating on a rigid polyamide-imide substrate textured with an abrasive and/or sodium or potassium hydroxide. The article relates the effect of various surface treatments on metal adhesion, and specifically to the combination of mechanical abrasion followed by a chemical treatment such as dipping in aqueous alkali metal hydroxide solutions. The article states that no advantage was observed with the use of nickel rather than copper for the initial metalization of the polymer, and concludes that the adhesion of the metal to the polyamide-imide substrate is a combination of both mechanical and chemical

factors related to the substrate.

Prior to the present invention, there has been no commercially viable method available for the direct coating of polyimide films with electrically conductive layers, without the use of an adhesive exhibiting adequate properties for general use in electronic circuitry. Adhesiveless laminates with metal on both sides have not been available due to the tendency for an electroless metal layer to blister during deposition onto both sides of a thin film, and to the destruction of polyimide to metal adhesion by thermal shock upon immersion in molten solder or because of undesirable reduction of film strength due to texturing. The problem of electroless metal blistering is especially acute in the complete metalization of thin polymeric film; hydrogen evolution during the deposition process has been suggested as a cause of electroless metal blistering. Electroless metal blistering on thin polymeric substrates is greatly reduced when the metal deposition is restricted to certain areas on the film (i.e., other than complete surface coverage).

The phrase thermally stable double sided adhesiveless laminate structure used herein refers to a double sided, polyimide based, laminate structure capable of not only passing IPC test methods 2.2.9 (peel strength) and 2.4.13 (solder float resistance) as written but also capable of passing the much more rigorous modifications of these test methods described below.

Both IPC test methods 2.4.9, Peel Strength, Flexible Printed Wiring Materials, and 2.4.13 Solder Float Resistance, Flexible Printed Wiring materials specify that when testing double sided laminates the Copper cladding on the non test side is or may be removed. After removal of the one copper layer and prior to any test inducing thermal shock or rapid high temperature treating test specimens are dried under specified conditions to remove absorbed moisture from the materials. Without these copper removal and drying steps prior to thermal stress both adhesive based and adhesiveless based laminates, prior to that described herein are prone to blistering and/or catastrophic adhesive loss during thermal shock or prolonged high temperature heating.

A test to investigate the effects of prolonged high temperature heating designed to test the thermal durability of an adhesiveless laminate structure under multilayer laminating conditions typically used in the flexible circuit industry is described below and is referenced herein as Modified Thermal Cycling IPC Test Method 2.4.9 Method E or F.

The sample of the double sided adhesiveless laminate to be tested is placed in a cold laminating press between two sheets of Kraft paper, and held flat with two steel platens also referred to as caul plates in the industry. The platens are pressurized to 350 PSI, the temperature is raised to 350°F and once the high temperature is attained, the sample is held at that temperature and pressure for one hour. The sample is then allowed to cool to room temperature, the pressure is released and the cycle is repeated twice more. Once the sample has passed through this sequence of steps it is then tested for peel strength adhesion as in IPC Test 2.4.9 Method A. Adhesion values of at least 2.5 lbs./inch are confirmation of a useful laminate material.

The test is designed to imitate actual laminating conditions anticipated during circuit manufacture. Removal of the metal cladding and subsequent polyimide conditioning prior to testing is not allowed. This test will be referred to herein as Modified Thermal Cycling IPC Test 2.4.9, Method E or F.

Experience has shown this test, Modified Thermal Cycling IPC Test 2.4.9, Method E or F, to be much more demanding and revealing than any of the following tests:

- IPC 2.4.9 Method C
- IPC 2.4.9 Method D
- IPC 2.4.9 Method E
- IPC 2.4.9 Method F
- IPC 2.4.13 Revision D

when samples are tested via these procedures either as written or using a modified procedure where removal of one copper layer and subsequent polyimide conditioning is not allowed.

It would be desirable to provide a process for coating at least one surface of a polyimide film with electrolessly deposited metal, followed by electrolessly deposited copper having sufficient adherent strength to the polyimide and sufficient resistance to thermal shock to render the resultant laminate useful for fabricating electronic circuits.

#### SUMMARY OF THE INVENTION

The present invention is directed to a process whereby a polyimide sheet or continuous web of polyimide film is uniformly coated on one or both surfaces with a strongly adherent electroless nickel or cobalt layer followed by an electrolytic copper layer. The polyimide film coated with nickel or cobalt with or without a thin copper coating on the nickel or cobalt coating is mechanically worked to form microcracks and hence inducing porosity in the initial thin metal coating. The mechanically worked laminate then is heated to volatilize any volatilizable components, such as moisture in the laminate. The resultant laminate then is coated with electrolytic copper on both surfaces.

Adherent layers of exposed copper are uniformly plated on one or both sides of the sheet and metal layers of controlled thickness are produced which provide laminates useful for the production of electronic circuitry. These laminate structures are suitable of general use in the production of electronic circuitry. The terms "web", "sheet" and "film" are used herein interchangeably and refer to thin flat, flexible polymer substrates.

In accordance with this invention, as a first step, the polyimide surface is contacted with an aqueous composition which renders the polyimide surface hydrophilic and facilitates absorption of a catalyst for effecting electroless nickel or cobalt deposition. The polyimide surface is then contacted with such a catalyst, e.g., colloidal palladium in order to provide a catalytic surface for the deposition of electroless nickel or cobalt. As used herein, the term "nickel" as it relates to the initial metal layer, includes nickel metal or a nickel containing alloy such as nickel/phosphorous, nickel/boron, etc. Also as used herein, the term "cobalt", as it relates to the initial metal layer includes cobalt metal or a cobalt containing alloy.

In accordance with this invention, the polyimide sheet coated with nickel or cobalt on both surfaces is mechanically worked to form microcracks in the nickel or cobalt. The mechanical working can be effected either prior to or subsequent to coating the nickel or cobalt surfaces with a thin layer (less than about 1.2  $\mu\text{m}$ ) of copper within which microcracks also can be formed. The mechanically worked and microcracked nickel or cobalt coated laminate then is heated to volatilize the volatilizable components of the polyimide film core, such as water. As a final layer, electrolytic copper is applied to the laminate on both surfaces to the desired thickness. Because they have a nickel or cobalt initial metal layer these laminates exhibit outstanding performance similar to that described in the related USP 4,725,504 when tested according to IPC test procedures 2.4.9 (March 1986 update) and 2.4.13 (June 1986 update). Because they have the nickel or cobalt initial layer and have been thermally stabilized by the method described herein, they also perform well under modified IPC 2.4.9 and 2.4.13 procedures where removal of one copper layer and subsequent polyimide conditioning is not allowed. They also perform well under the stringent Modified Thermal Cycling IPC Test 2.4.9 Method E or F described above.

Prior to this present invention, no double-sided adhesiveless laminate, were capable of passing this more stringent test.

#### BRIEF DESCRIPTION OF THE DRAWINGS

Figure 1 shows the embodiment of this invention where polyimide film is coated on both sides with nickel or cobalt and copper.

Figure 2 shows a typical circuit used in Tape Automated Bonding (TAB) producible using a laminate of this invention.

Figure 3 is an SEM (scanning electron micrograph), at 500X magnification, showing the textured film made by the method of DeAngelo as outlined in Example 2 of this application.

Figure 4 is an SEM at 500X magnification, showing the textured film made by the method of Redmond as outlined in Example 7 of this application.

Figure 5 is an SEM at 500X magnification, showing film treated by the modified method of DeAngelo (where potassium hydroxide is substituted for sodium hydroxide) as outlined in Example 2 of this application.

Figure 6 is an SEM at 500X magnification, showing film treated by the single phase composition as is used by the method of this invention, and as outlined in Example 2 of this application.

Figure 7a is an SEM at 500X magnification of non-microcracked nickel coating forming a layer of the laminate of this invention.

Figure 7b is an SEM at 250X magnification of the nickel coating as in Figure 7a containing microcracks.

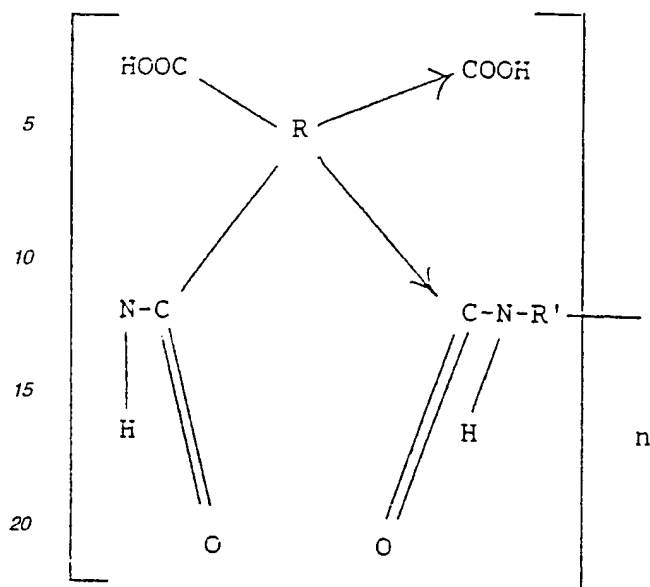
Figure 8 is a diagram of the cracking apparatus used to produce the microcracks in the electroless nickel or electroless nickel and thin electrolytic copper layers as described in the method of this invention.

Figure 9 is a three component mixture diagram showing weight loss at each texture composition from Example 9.

Figure 10 is a three component mixture diagram showing contour lines of percentage weight loss for texturant compositions as described in Example 9.

#### DESCRIPTION OF THE SPECIFIC EMBODIMENTS

In the preferred embodiment of this invention, the polyimide surfaces treated are of the type prepared from a polyamide-acid (also referred to as polyamic acid) which has the formula:



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where the arrows denote isomerism, R is an organic tetravalent radical containing at least two carbon atoms, no more than two carbonyl groups of each polyamic acid unit being attached to any one carbon atom of said tetravalent radical; R' is a divalent radical containing at least two carbon atoms, the amide groups of adjacent polyamide-acid units attached to separate carbon atoms of divalent radical and  $n$  is a positive integer sufficient to provide the polyamic acid with an inherent viscosity of at least 0.1. The most preferred of such polyimides is Kapton (Trademark registered to DuPont) and Apical (Trademark of Allied-Signal co.) which are the polyimides formed from pyromellitic anhydride,

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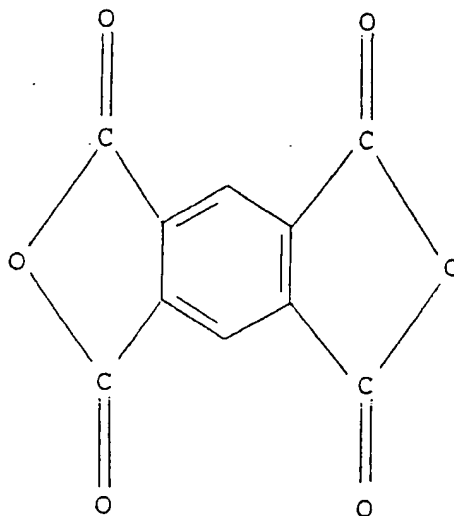
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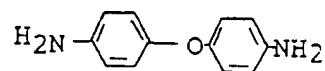
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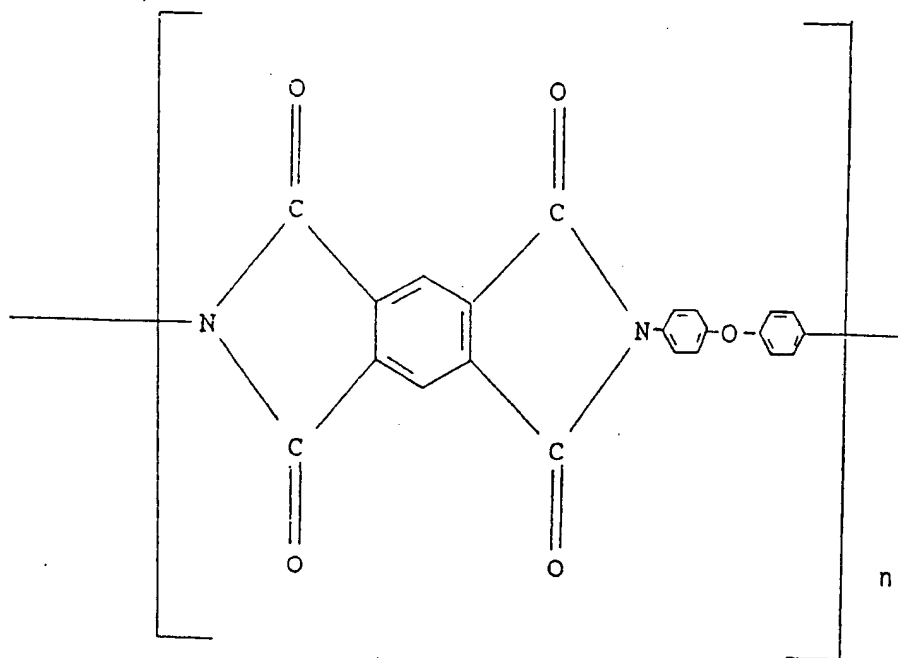
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and 4,4' -diamino-diphenyl ether,

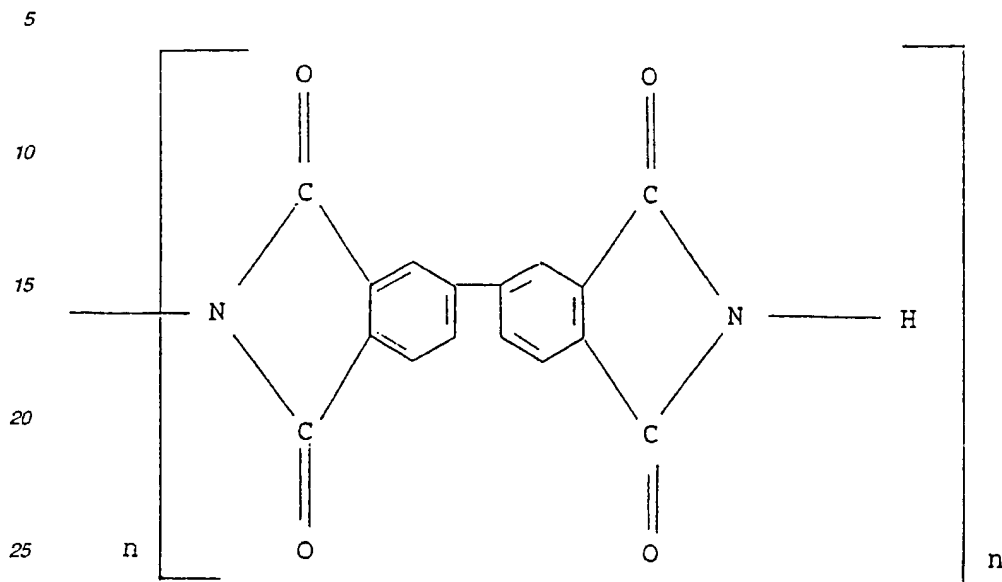


and having the general formula:



where n is an integer ranging from 150 to 650 and which has an average molecular weight of 60,000 to 250,000.

The above polyimides and their preparation are described in U.S. Patents 3,179,614 and 3,179,634 to Edwards, which are incorporated herein by reference. Other examples of suitable polyimides are the Upilex polyimides available from ICI America, Inc. Upilex S polyimide is formed from the anhydride of the formula:



30 and a diamine.

The polyimide can have any thickness suitable as a substrate for electronic circuitry, and most generally is in the form of a relatively thin sheet having a thickness of between about 12 and 125  $\mu\text{m}$ . Hitherto a polyimide film coated on both sides with a permanently bonded metal comprising electroless nickel or cobalt followed by electrolytic copper capable of surviving modified IPC tests 2.4.9 and 2.4.13, where removal of one copper layer and subsequent polyimide conditioning are not allowed as well as the "Modified Thermal Cycling IPC Test 2.4.9, Method E or F described below has not been available. Tests for thermal cycling are designed to test the thermal durability of the laminate product of this invention under the conditions of alternating (a) high temperature and pressure and (b) room temperature. The modification of IPC test 2.4.9 Method E described herein is intended to simulate conditions that would be experienced by the laminate material during the manufacture of a typical multilayer circuit product, wherein the laminate of this invention would make up one or more of the multiple circuit layers. The actual test used is as follows:

A sample of the laminate to be tested is placed in a cold laminating press between two sheets of Kraft paper, and held flat with two steel platens also referred to as caul plates in the industry. The platens are pressurized to 350 PSI, the temperature is raised to 350°F and once the high temperature is attained, the sample is held at that temperature and pressure for one hour. The sample is then allowed to cool to room temperature, the pressure is released and the cycle is repeated twice more. Once the sample has passed through this sequence of steps it is then tested for peel strength adhesion as in IPC Test 2.4.9 Method A. Adhesion values greater than approximately 3 lbs./inch are confirmation of a useful laminate material.

The test is designed to imitate actual laminating conditions anticipated during circuit manufacture. The removal of the metal cladding and subsequent polyimide conditioning prior to testing is not allowed. This test will be referred to in the specification and claims as "Modified Thermal Cycling IPC Test 2.4.9, Method E or F.

Two basic techniques for preparing electronic circuits which involve removal of unwanted metal are briefly outlined below.



<u>Semi-Additive Process</u>	<u>Subtractive Process</u>	
Thin Laminate (e.g., 0.5-8 $\mu\text{m}$ metal)	Thin Laminate (e.g., 35 $\mu\text{m}$ metal)	
Apply resist	Apply resist	5
Photoimage	Photoimage	
Develop resist	Develop resist	
Electrolytic copper plate (e.g., 35 $\mu\text{m}$ )	Etch unmasked metal	
Strip resist	Strip resist	10
Etch to remove thin laminate metals in non-circuit areas		

No modification of existing procedures for the production of said circuitry is necessary using laminates of this invention. A further advantage for the use of the method of this invention is that metal thicknesses can be provided easily from extremely thin to very thick layers. Laminates with layers of metal less than about 18  $\mu\text{m}$  (1/2 ounce) are difficult to produce using present adhesive laminate production methods with metal foils, but are easily produced in a continuous roll-to-roll plating process by the method of this invention.

The polyimide film surface should be relatively clean, but a cleaning or degreasing step may be performed (if necessary) prior to contact with the hydrophilizing composition and catalyst for effecting electroless metal deposition.

Suitable hydrophilizing compositions are those which improve the water wettability of the polyimide surface and which are commonly available in the art including potassium hydroxide, a sodium hydroxide or any caustic composition which can be used alone or with a lower alkanol such as methanol or ethanol, chromic acid or the like or texturizing compositions which do not adversely affect the mechanical properties of the polyimide surfaces. It is believed that the mechanism for improving water wettability of the polyimide surfaces involves ring opening of the polyimide molecular structure.

As an example of the use of a texturizing composition, a polyimide sheet is first treated with a one-phase solution of an alkali metal hydroxide, an alcohol, and a diamine of the formula  $\text{H}_2\text{N}(\text{CH}_2)_n\text{NH}_2$  wherein  $n$  is an integer from 2 to 6, preferably ethylenediamine, to provide a textured and hydrophilic surface, where a uniformly and completely textured surface of a particular topography is produced and the mechanical bulk properties of the film are substantially unaffected. The one phase solution should have sufficient solvent affinity for the polyimide from each surface but should not have such a high affinity for the polyimide to materially reduce the mechanical strength of the polyimide sheet, below that of an untreated film having essentially the same thickness. Suitable one phase three component solvent composition can be determined by the method set forth in Example 9, and Figures 9 and 10. Representative suitable one phase solvent compositions comprise 5 to 25 weight percent diamine, 3 to 40 weight percent alkali metal hydroxide and 10 to 50 weight percent alcohol or a mixture of alcohols one of whose function is to act as cosolvent and provide a one phase solution and the balance water. The particular weight percent of each of the three components of the texturant composition will vary depending upon the components employed. In each case, however, the degree of milling and the determination of whether the texturant composition is one phase can be obtained by the procedure of Example 9 to generate figures such as Figure 9 and 10 to determine suitable weight percents of the three components. The surface of the textured film is characterized by nodules or bumps, rather than pits as reported for other texturing methods. When viewed through a microscope, the completeness of surface texturing is readily seen. Scanning Electron Micrographs (SEM) of the film textured by the methods of U.S. Patents 3,791,848 and 4,078,096 to DeAngelo and Redmond respectively, are shown in Figures 3, 4 and 5 as compared to the film textured by the method of this invention as shown in Figure 6. The substantially complete texturing produced by this method can be seen by the more pronounced and uniform appearance of the surface features, (bumps) as compared to the film produced by either of the other prior art methods which are smoother in appearance and therefore not as completely textured.

The surface of the film is rendered uniformly frosted and matte with a translucent appearance so that a surface receptive to colloidal catalyzation and the subsequent electroless deposition of an electrically conductive metal layer is provided, yet the original mechanical bulk properties of the film are substantially unaffected.

Once the clean polyimide surface has been rendered hydrophilic the film is catalyzed with any one of the catalyst systems well known to those versed in the art of electroless plating. Catalyst combinations which can be used in conjunction with the sensitized polyimide surface are disclosed in U.S. Patents 3,011,920 and 3,562,038 which are incorporated herein by reference. The catalyst may be applied in a two step application, by first depositing the sensitizer and then the noble metal activator; however, these baths may be combined in a one step operation, e.g., a black colored tin- palladium colloidal dispersion.

The catalyzing is provided for a period of one to five minutes, and then the sample is immersed in an acidic solution to remove tin from the surface in a process referred to as acceleration. The sample is then placed in an electroless nickel or cobalt bath for a period ranging from about two to ten minutes to provide the desired

thickness of nickel.

Suitable electroless nickel baths are disclosed in U.S. Patents 3,062,666; 3,140,188; 3,338,726; 3,531,301; 3,537,878; and 3,562,038 which are incorporated herein by reference. Some typical formulations are shown:

5	1. Nickel chloride ( $\text{NiCl}_2 \cdot 6\text{H}_2\text{O}$ )	20.0 g/l
	Sodium hypophosphite ( $\text{NaH}_2\text{PO}_2 \cdot \text{H}_2\text{O}$ )	60.0 g/l
	Ammonium oxalate ( $(\text{NH}_4)_2\text{C}_2\text{O}_4 \cdot \text{H}_2\text{O}$ )	40.0 g/l
10	Ammonium Hydroxide 25%	60 ml/l
	pH 8.2, 85° C	
15		
	2. Nickel Sulfate ( $\text{NiSO}_4 \cdot 6\text{H}_2\text{O}$ )	20.0 g/l
20	Dimethylamine Borane	3.0 g/l
	Citric Acid	10.0 g/l
	Conc. HCl	25.0 ml/l
	pH 5.2-5.5, 95° C	
25	Ammonium Hydroxide	to pH 7.0
	2-mercaptobenzothia- zole	0.5-2.0 mg/l
	65° C	
30		
	3. Nickel Sulfate ( $\text{NiSO}_4 \cdot 6\text{H}_2\text{O}$ )	17.1 g/l
	Sodium Hypophosphite ( $\text{NaH}_2\text{PO}_2 \cdot \text{H}_2\text{O}$ )	14.0 g/l
35	Acetic Acid 80%	12.0 g/l
	$\text{MoO}_3$ 85% (adjust to control rate)	5.0 mg/l
40	pH 5.2-5.5, 95° C	
	4. Nickel Chloride ( $\text{NiCl}_2 \cdot 6\text{H}_2\text{O}$ )	16.0 g/l
45	Dimethylene Borane	3.0 g/l
	Sodium Citrate	18.0 g/l
	Glycine	8.0 g/l
50	Bismuth Nitrate	20.0 mg/l
	Thiorea	15.0 mg/l
	pH 7.0, 65° C	

55 Nickel or cobalt is deposited on the receptive surfaces by electroless deposition to form a metal coated surface. Nickel ions are reduced in this process onto the catalytic surface to form a continuous electrically conductive layer. The electroless layer must be sufficiently thick to permit the subsequent electrolytic deposition of a uniform copper layer. Generally, the electroless nickel or cobalt layer is between about 0.2  $\mu\text{m}$  and 1.0  $\mu\text{m}$  thick but can be thicker if desired.

60 The use of nickel rather than copper as an initial metal layer provides several significant advantages. Most importantly, in sharp contrast with the characteristics of the copper/polyimide interface the nickel/polyimide interface is not degraded at high temperature (~176° C, 350° F). However, it should also be stated that both the copper/polyimide and nickel/polyimide interfaces are degraded at high temperatures (~176° C, 350° F) if moisture is present at the metal/polyimide interface. Thus the essence of this application is the novel process whereby a double sided, nickel or cobalt based adhesiveless laminate with little or no water in the polyimide  
65 core is produced. Prior to this invention no double sided adhesiveless laminates with equivalent thermal

stability characteristics were obtainable. Unexpectedly, it has been found that electroless nickel/boron alloys etch more easily than electroless nickel/phosphorous alloys when standard copper etchants such as cupric chloride are used. The nickel/boron alloy producing baths are easier to use with a continuous reel to reel process and are not as prone to catastrophic decomposition as are nickel/phosphorous baths. It is preferred to utilize electroless nickel baths wherein the reducer for the nickel is dimethylamine borane (DMAB), since the resultant nickel coating can be subsequently etched with a common etching solution such as cupric chloride. Copper is not useful as interfacial metal layer since it can catalyze thermal degradation of the polyimide and lead to poor post solder float and thermal cycle peel strength values due to the thermal sensitivity of the copper/polyimide interface.

While the double metal coated laminate product described and claimed in the related U.S. Patent 4,725,504 provides substantial advantages over prior art laminates, it is characterized by inconsistent resistance to thermal cycling or the Modified Thermal Cycling IPC Test 2.4.9 Method E or F. That is, the product tends to develop reduced metal adhesion and thus peel strengths when exposed to repeated conditions of high temperature of the order that would be experienced in the production of the typical multilayer circuit board. For this reason its utility is limited to circuitry where little or no lamination is required, as for example the production of TAB (tape automated bonding) circuits. A major use of such laminates presently is in multilayer circuits wherein the laminates, in the form of double sided circuits are adhesively bonded to each other under conditions of high temperature and pressure, usually in a stack of three to five laminates or more.

If the laminates experiences reduced peel strengths to below an acceptable minimum peel strength, it cannot be used for multilayer circuits. In accordance with the present invention, it has been found that, after the nickel or cobalt layers have been coated on the polyimide surface, if the resultant laminate is mechanically worked to form microcracks in the metal surface, followed by heating, the product formed after the electrolytic copper of desired thickness is coated on the nickel or cobalt is characterized by excellent resistance to Modified Thermal Cycling IPC Test 2.4.9 Method E or F. The microcracks can be formed into the nickel or cobalt coating either directly or after a thin layer of electrolytic copper has been coated on one or both of the nickel or cobalt layers. The initial flash copper layer has a thickness such that microcracks form therein during the mechanical working. The electrolytic copper layer should be approximately 1.0  $\mu\text{m}$ .

The mechanical working step can be conducted by a variety of means including passing the laminate in contact over a dull knife edge or any other means where porosity of the initial metal layer(s) is increased without significantly changing the resistive properties of the thin metal layer(s). The preferred method for forming microcracks inducing porosity in the metal layer or layers will be described below in detail with reference to Figure 8. However, the scope of this invention is not limited by the microcracking technique. Other techniques which serve to increase the porosity of the initial metal layer without significantly changing the resistive properties include the use of shot peening, corrosive chemical fog, and low temperature thermal shock can be utilized.

Referring to Figure 8 of the drawings, microcracking is obtained when a web of laminate 10 is passed over idler roller 12, support rollers 14 and 22 are cracking roller 16. Cracking roller 16 has a sufficiently small diameter so that the compression forces on the underside surface 18 of laminate 10 and the tension forces on the topside surface 20 of laminate 10 are sufficient to cause the formation of microcracks in the metal layers of one or both surfaces 18 and 20. The laminate 10 then is passed over idler roller 24. The microcracks run generally parallel to the main axis of roller 16. The laminate having the microcracks therein then is heated to a temperature at which volatilizable components such as moisture in the polyimide layer can volatilize and escape the laminate through the microcracks. The heating can be conducted in any convenient manner such as by baking in an oven or passing the laminate through a heated inert oil such as silicone, fluorocarbon, or peanut oil. The heating is conducted at a temperature and for a time sufficient to effect substantial removal of the volatilizable materials from the polyimide sheet without degrading the polyimide or metal layers. Generally, heating is effected at a temperature between about 165°C and 225°C, preferably between about 180°C and 210°C for a period of about 5 to 20 minutes. The microcracked and baked film can then be electroplated at a lower temperature without readsorbing deleterious amounts of water into the core polyimide film presumably since the transport rate of water vapor through the cracked nickel film is much higher than that of water from the aqueous process solutions. In order to improve the subsequent electrolytic deposition, the metal surfaces are cleaned to remove or reduce the metal oxides thereon. The passive nickel oxide layer can be removed with an acid cleaner which should not be so strong as to remove the nickel layer itself. Suitable cleaners are aqueous solutions of sulfamic or citric acid. The resultant laminate is then coated with electrolytically deposited copper to the desired thickness.

A serious deficiency of prior double sided adhesiveless laminates is their failure and loss of bond strength when subjected to standard high temperature processing conditions. The method of this invention provides thermally stabilized double sided adhesiveless laminates which provide products that pass solder float adhesion testing by IPC tests 2.4.9 and 2.4.13 as written as well as using a modified procedure where removal of one copper layer and subsequent polyimide conditioning is not allowed. These laminates are also characterized by a good performance in Modified Thermal Cycling IPC Test 2.4.9 Method E or F described above. The combination of proper polyimide film pretreatment and electroless bath chemistry and the method of this invention has provided a class of adhesiveless laminates that prior to U.S. Serial Number 155,897 were unavailable.

In particular, this invention provides a laminate with the following advantages over the prior art:

1. Single or double-sided adhesiveless laminate constructions with excellent adhesion.
2. Initial adhesion values superior to those obtained using electroless copper for both single- and double-sided laminate constructions.
3. Post solder float adhesion greater than that obtained by other methods, with no random failure of blowoff during solder float testing as per IPC Test 2.4.9 or 2.4.13.
4. Excellent resistance to thermal cycling effects encountered during multilayer circuit fabrication.
5. A superior laminate provided consistently with both sheet and roll-to-roll processing of the film.
6. Laminate structures can be provided having a very thin conductive layers produced at significant cost savings, and more reliably than those produced by prior methods.
7. Laminate structures with improved flex ductility when compared to the adhesive-based and adhesiveless laminates presently available.
8. Laminate structures which have improved dimensional stability when compared to adhesive-based laminates.
9. Metal coated laminates processable under conditions normally utilized for production of circuitry when a nickel/boron alloy is used for initial metallization.

The following examples illustrate the present invention and are not intended to limit the same.

#### EXAMPLE1

A 14 inch wide continuous web of type VN200 Kapton brand polyimide film is treated to render the surface hydrophilic and textured with an aqueous alkali metal hydroxide, methanol and ethylenediamine composition. The texturing composition is comprised of 37.4 percent by weight potassium hydroxide, 10 percent by weight methanol, and 7.0 percent by weight ethylenediamine (EDA) in an aqueous solution. Total film thickness is reduced from 48 to 41  $\mu\text{m}$  in the texturing process and the film has a uniformly and completely frosted appearance. This treated film is further processed on both surfaces with the following sequence:

1. 60 sec. at 25°C in 23% solution of an aqueous acid bath sold under the tradename, Cataprep 404 available from Shipley Company, Inc.
2. 120 sec. at 45°C in a 3% concentration of an aqueous colloidal palladium catalyst sold under the tradename, Cataposit 44 available from Shipley Company, Inc.
3. Rinse for 60 sec. in water.
4. 180 sec. at 25°C in a 10% solution of an acidic accelerator sold under the tradename, Shipley Accelerator 19 available from Shipley Company, Inc.
5. Rinse for 30 sec. in water.
6. 300 sec. at 65°C in an electroless nickel plating solution, utilizing dimethylamine borane as the reducing agent, sold under the tradename Niklad 752 from the Allied Kelite division of Witco Chemical Corp. Final nickel thickness approximates 0.5  $\mu\text{m}$ .
7. Pass the double nickel coated web through the apparatus of Figure 8, to effect microcracking of the nickel layer, wherein the diameter of roller 16 is 1/16 inch and the diameter of rollers 14 and 24 is 2 inches, and at a rate of three feet per minute.
8. Bake the microcracked laminate from step 7 in an oven at 190°C for 10 minutes.
9. Clean the samples for 30 seconds at 35°C in a solution containing 3% by weight of sulfamic acid.
10. Electroplate with copper for 90 minutes at 15 amps per square foot (ASF) in a brightened copper sulfate bath containing 25 ounces per gallon of sulfuric acid, 15 ounces per gallon of copper sulfate pentahydrate, 50-70 ppm chloride ion, and 1.0% of an organic brightener sold under the tradename Copperlume PTH-R by M&T Chemicals Co. This provides a laminate coated with about 35  $\mu\text{m}$  of copper.

After masking with chemically resistant tape, 1/8th inch lines are revealed using an acidic copper chloride etching solution to remove metal from unmasked areas of the sample. The tape is removed, the sample is dried and then an Instron Model 1000 Universal Testing Instrument is used to perform 90 degree peels using IPC Test 2.4.9, Method A. Average adhesion of 10.0 lb./in. on each side is obtained and no side to side variation is observed.

Other samples are then tested for adhesion after solder float as per IPC test 2.4.9, Method C. The etched lines are coated with less than 50  $\mu\text{m}$  of Dow Corning high vacuum silicone grease, and floated for five seconds on molten solder which is held at 288°C. No metal blowoff is observed on the 1/8th inch traces, and the final adhesion of these heat shocked materials was 4.8 lb./in.

Other samples were tested for resistance to thermal cycling by the Modified Thermal Cycling IPC Test 2.4.9 Method E. These samples were compared to double nickel coated samples which were not passed through Step 7 (microcracking) and to samples which were passed through Step 7 but were not baked as in Step 8. All samples were coated with electrolytic copper to the same thickness as described above. The average results are tabulated below.

# of Cycles	Cracked		Un- cracked (lb/in)
	(No Bake(lb/ in))	Baked(lb/ in)	
0	7.0	6.5(avg)	9.5
3	1.0	5.5(avg)	1.0

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EXAMPLE 2

Four inch by six inch samples of type VN200 Kapton brand polyimide film are textured by the four different compositions shown in the following table, then catalyzed by the procedure described in Example 1, and then metalized with either (a) an electroless copper bath containing formaldehyde as a reducing agent and sold under the tradename Enduroplate EP-407 by Hunt Chemical Co., or (b) the Niklad 752 electroless nickel/boron bath described earlier. The EP-407 bath is a low deposit electroless copper bath which has been found to provide the best results of commercial copper bath formulations tested on polyimide film textured by the method of this invention.

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TEXTURANT COMPOSITIONS

Texturant	NaOH	KOH	EDA	CH <sub>3</sub> OH	H <sub>2</sub> O
A - *	0.0%	41.8% (10.5M)	7.0%	0.0%	51.2%
B - **	28.0%	0.0% (9.1M)	7.0%	0.0%	65.0%
C	0.0%	37.4%	7.0%	10.0%	45.6%
D	27.7%	0.0%	7.0%	10.0%	55.3%

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\* - Texturant from Example 1D, U.S. Patent 3,791,848 to DeAngelo, where 45 percent by weight potassium hydroxide is substituted for 10 N sodium hydroxide.

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\*\* - Texturant from Example 1D, U.S. Patent 3,791,848 to DeAngelo.

- Texturants C and D are homogeneous single phase liquid compositions in accordance with this invention.

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Figure 3 shows the surface resulting from the use of Texturant B. This result is compared to the surface resulting from the use of Texturant D as shown in Figure 6. The use of Texturant D results in a uniform and completely textured (bumped) surface. The surface resulting from the use of Texturant B is incompletely textured as shown by the lack of surface features or roughening. As shown in Figure 6, the surface resulting from the use of Texturant A has very little surface modification.

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These samples are then electrolytically copper plated to a final metal thickness of approximately 35  $\mu$ m. IPC test 2.4.9, Methods A and C were then performed for initial and post solder float adhesion, respectively, with the following result:

Sample number	Texturant	Initial Metal	Initial (lb./in.)		Solder Float Peel (lb./in.)
			Side A	Side B	
1	A	Ni	5.2	6.4	0.3
2	A	Cu	4.8	4.8	BLOWOFF
3	B	Ni	7.4	8.5	0.4
4	B	Cu	6.7	8.4	BLOWOFF
5	C	Ni	7.9	6.8	4.6
6	C	Cu	6.5	8.0	BLOWOFF
7	D	Ni	9.4	10.0	4.4
8	D	Cu	7.5	7.1	BLOWOFF

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All reported adhesion values are for peels at 90 degrees for 1/8th inch traces performed using an Instron model 1000 universal tester. An average of at least three 1/8th inch traces are used for each value shown in the

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table above. Two major conclusions can be drawn from the information presented in the table above:

1. The homogeneous texturing solution of this invention such as that represented by Texturant C or D provides overall superior solder float performance.
2. Nickel metalization provides superior post solder float performance.

5 In every case the combination of either Texturant C or D, and the use of electroless nickel provides a superior laminate to that produced by the application of the two-phase texturant as taught by DeAngelo. The samples using the nickel for initial electroless metalization show more consistent adhesion values which are much higher overall than those obtained with the electroless copper samples. There is no random blowoff on solder float as is found for samples that are metalized initially with electroless copper.

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### EXAMPLE 3

15 A four inch by six inch sample of type VN200 Kapton brand polyimide film is prepared as in Example 1 up to the electroless nickel step, but is only plated on one side with electrolytic copper. This selective plating is accomplished by coating one side of the sample with a plating resist. The final laminate structure is comprised of double-sided electroless nickel and 35 um of electrolytic copper on one side only. This sample is subjected to a more rigorous test than IPC test 2.4.13, "Solder Float Resistance-Flexible Printed Wiring Materials" wherein the sample is tested without removing metal from either side; the samples are cut into two-inch squares, baked at  $135 \pm 10^\circ\text{C}$  for one hour; then floated for 10 seconds on solder held at  $260 \pm 5^\circ\text{C}$ . This sample suffers no blowoffs or delaminations.

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### EXAMPLE 4

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A four inch by six inch sample of type VN200 Kaptron brand polyimide film is laminated on one side with tape, with a water resistant low tack adhesive, and textured as in Example 1. After pretreatment in a palladium catalyst solution, the tape is removed, followed by electroless nickel buildup, and electrolytic plating to 35 um in a brightened acid copper sulfate bath by the method of Example 1. After plating, 1/8th inch lines are revealed using a copper chloride etchant. After removing surface moisture at  $80^\circ\text{C}$  for 30 minutes, one half of the lines are peel tested for adhesion before solder float, the other half of the lines are subjected to a solder float, and then peel tested as in IPC test 2.4.9, Methods A and C yielding values of 8-9 lb./in., and 4.8 to 5.0 lb./in., respectively.

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### EXAMPLE 5

This example illustrates the usefulness of the laminates produced by the method disclosed herein for the preparation of circuits by the subtractive method set forth above. Laminate constructions are prepared on type VN200 Kapton brand polyimide film using the procedure of Example 1 on one side of the film up to the point of electrolytic metalization. To prevent treatment of the other side of the film one side of the sample is masked with tape, and the tape is removed just before electroless metalization. For the preparation of a particular type of printed circuit pattern referred to as a TAB (Tape Automated Bonding) circuit (Figure 2) which is used as a chip carrier for mounting integrated circuits (chips) by the subtractive method, the copper is only electroplated to about 18 um in a brightened copper sulfate bath.

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The laminates are first cleaned for one minute at  $35^\circ\text{C}$  in a 1.0 M NaOH solution containing a wetting agent, followed by cleaning for 30 seconds at  $25^\circ\text{C}$  in 1.0% aqueous nitric acid, followed by thorough water rinsing and drying of the sample. The laminates are next coated with a positive liquid photoresist available from Shipley Corp. under the tradename Shipley AZ-119S. A final dry film thickness of 5 um is obtained after drying at  $80^\circ\text{C}$  for 30 minutes as per manufacturers instructions. A positive photoresist coating is a composition which becomes soluble in an aqueous developing solution on exposure to ultraviolet (UV) light energy. The resist coated laminate is then masked with a phototool and exposed using a NuArc 26-1K ultraviolet exposure unit at 200 millijoules per square centimeter to image the TAB circuit pattern. The exposed resist is then developed in a two stage treatment using Shipley 303A developer from Shipley Corp. The sample is immersed for two minutes in a 25% concentration of the developer followed by 30 seconds in a 20% solution of the developer. A clean, sharp resist image of the TAB circuit pattern is obtained. The resist is then post baked to harden for one hour at  $125^\circ\text{C}$ . The exposed copper and underlying electroless nickel is removed in a copper chloride etchant.

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The method of this Example produces a TAB circuit as shown in Figure 2 with clean line definition of at least 75-100 um.

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### EXAMPLE 6

65 A double-sided copper clad laminate of the type shown in Fig. 3 is prepared by the procedure of Example 1

and tested in accordance with IPC test 2.4.13 as follows:

1. One side of the sample is masked with tape.
  2. The metal is then removed from the unmasked side in a copper chloride etchant, and the tape mask is removed.
  3. A two-inch square is cut from the specimen.
  4. The sample is then placed in an oven at  $135 \pm 5^\circ \text{C}$  for one hour.
  5. The surface is cleaned by the use of an acid flux.
  6. The sample is floated for 10 seconds just beneath the surface of molten solder held at  $250 \pm 10^\circ \text{C}$ .
  7. The uncoated side of the sample is then inspected for metal delamination and separation from the polyimide surface.
- No areas of delamination were found, and no separation at the metal/polymer interface was observed.

#### EXAMPLE 7

A four inch by six inch sample of type VN200 Kapton brand polyimide film is textured with a 60% Hydrazine-9.3% caustic solution as disclosed in Table II of U.S. Patent 4,078,096 to Redmond et al. The treated sample is then plated in accordance with Example 1 of this application. An average peel strength of only 4.0 lb./in. is obtained for samples prepared in this manner. The bond failure appears to be within the polymer film itself, which is a good indication that the cohesive strength of the film has been reduced.

As shown by Figure 4, the Redmond et al treated surface is incompletely and non-uniformly textured. In contrast, the polyimide surface treated in accordance with this invention has a uniformly and completely textured surface.

#### EXAMPLE 8

Six four inch by six inch pieces of 2.0 mil Apical film from Kanegafuchi Corp. and sold through the Allied Signal Corporation, are textured, electrolessly nickel/boron plated on both sides of the film, microcracked and baked followed by the electrolytic copper buildup to 35 um according to the method of Example 1. Apical film is reported to be chemically identical to Kapton brand polyimide film, and this Example illustrates the applicability of the method of this invention to other commercially available polyimide films. The Apical film textures well although the nodular bumps are of slightly larger size than those on Kapton brand polyimide film, and when the Apical is electrolessly nickel/boron plated it has a more lustrous appearance than Kapton polyimide film. The following results are an average of the six samples.

# of Cycles	Cracked/Baked Adhesion (lb/in)
0	6.5(avg)
3	5.5(avg)

#### EXAMPLE 9

In order to determine the possible texturant compositions, a three component mixture phase diagram was prepared, the miscible regions were defined, and the two phase regions were eliminated from the experimental design. Representative mixtures were identified, and then investigated in order to get more specific data. For these experiments, 100 gms of each texturant composition shown in the following table were prepared, and three 3 inch square samples of Kapton were treated in each solution for 60 seconds at  $35 \pm 2^\circ \text{C}$ . The weight loss for each sample was measured, and the samples were viewed under a light microscope for a qualitative comparison of the bumping which resulted from each treatment.

	SAMPLE	WGT % MeOH	WGT% EDA	WGT % 45%KOH	AVG of 3 %WGT LOSS	TEXTURE HI/MED/LO
	A	10	5	85	28.6	MED
5	B	90	5	5	12.7	NONE
	S	18	77	5	8.7	LO
	D	36	32	32	27.0	MED
	E	50	5	45	9.5	LO
10	F	50	45	5	7.4	LO
	G	20	40	40	2 PHASE	
	H	10	20	70	42.6	HI
	I	20	60	20	13.8	LO
	J	25	18	57	30.7	HI
15	K	63	18	19	1.1	NONE
	L	40	40	20	9.0	LO

Figure 10 shows the location of contour lines for the degree of milling to be expected for any of the single phase compositions possible for these three components. These lines are approximate, and show that there are many possible variations in the exact texturant compositions that will both mill and texture the polyimide films. In all of the diagrams the two phase mixture is shown, and the DeAngelo texturants, which do not provide the uniformly bumped surface as the single phase mixture of use in the method of this invention fall into this two phase area. Note that the texturant composition at the lower right vertex of the mixture diagram mills the film to some extent; However, this composition contains too little ethylene-diamine to cause a bumped and nodular surface to the polyimide film.

The following examples illustrate that polyimide films of various commercial brands and grades, the surfaces of which have not been rendered substantially and completely textured as described in the preceding Examples, but which are rendered hydrophilic by methods well known to those versed in the art can be utilized to produce laminates, via this invention, having two metal surfaces and good performance in the modified IPC Test 2.4.9 Method E or F described above. The examples also clearly show by comparison the unique circuit manufacturing advantages of laminates produced by the method of this invention.

#### EXAMPLE 10

A 14 inch wide continuous web of type VN 200 Kapton brand polyimide film is treated to render the surface hydrophilic with a solution formed by mixing 18.5 gallons of a 45% KOH aqueous solution and 6.5 gallons of methanol at 22° C for a dwell time of 45 seconds. The film then was washed extensively with water. The film, as viewed under a microscope, was untextured in that the surface was smooth in appearance. This treated film is further processed on both surfaces with the following sequence.

1. 60 sec. at 25° C in 23% solution of an aqueous acid bath sold under the tradename, Cataprep 404 available from Shipley Company, Inc.
2. 120 sec. at 45° C in a 3% concentration of an aqueous colloidal palladium catalyst sold under the tradename, Cataposit 44 available from Shipley Company, Inc.
3. Rinse for 60 sec. in water.
4. 180 sec. at 25° C in a 10% solution of an acidic accelerator sold under the tradename, Shipley Accelerator 19 available from Shipley Company, Inc.
5. Rinse for 30 sec. in water.
6. 300 sec. at 65° C in an electroless nickel plating solution, utilizing dimethylamine borane as the reducing agent, sold under the tradename Niklad 753 from the Allied Kelite division of Witco Chemical Corporation. Final nickel thickness approximates 11.24 to 11.74 microinches.
7. A sample of the laminate from step 6 is retained, another is passed through the apparatus of Figure 8, to effect microcracking of the nickel layer, wherein the diameter of roller 16 is 0.109 inches and the gap between rolls 14 and 22 is 0.009 inches.
8. Bake the microcracked laminate from step 7 in an oven at 196° C for 13 minutes, 20 seconds.
9. Clean the samples for 30 seconds at 35° C in a solution containing 3% by weight of sulfamic acid.
10. Electroplate with copper for 90 minutes at 15 amps per square foot (ASF) in a brightened copper sulfate bath containing 25 ounces per gallon of sulfuric acid, 15 ounces per gallon of copper sulfate pentahydrate, 50-70 ppm chloride ion, and 1.0% of an organic brightener sold under the tradename Copperlume PTH-R by M&T Chemicals Co. This provides a laminate coated with about 1 oz./ft.2 of copper.

An Instron Model 1000 Universal Testing Instrument is used to perform adhesion testing as per Modified Thermal Cycling IPC Test 2.4.9 Method F previously described. The average adhesion values are tabulated below.



## Modified Thermal Cycling Test 2.4.9 Method F

Adhesion Testing (lb/in)			
	Case 1	Case 2	
	Microcrack and Bake	No Microcrack No Bake	
0 Cycle	4.8	6.1	
1 Cycle	5.0	0 "blow off"*	
2 Cycle	5.2	0 "blow off"	
3 Cycle	5.4	0 "blow off"	

The comparative data and uniform failure modes from Case 1 clearly show the utility of the microcrack and bake process and that the thermal stabilization process is independent of surface texture.

\* The term "blow-off" implies catastrophic delamination or blistering at the metal polyimide interface.

EXAMPLE 11

A 14 inch wide continuous web of type VN 100 Kapton brand polyimide film is treated to render the surface hydrophilic and with a solution formed by mixing 18.5 gallons of a 45% KOH aqueous solution and 6.5 gallons of methanol at 22°C for a dwell time of 45 seconds. The film then was washed extensively with water. The film, as viewed under a microscope, was untextured in that the surface was smooth in appearance. This treated film is further processed as in Example 10 with the exception of step 7 where:

7. A sample of the laminate from step 6 is retained, another is passed through the apparatus of Figure 8, to effect microcracking of the nickel layer, wherein the diameter of roller 16 is 0.055 inches and the gap between rolls 14 and 22 is 0.007 inches.

An Instron Model 1000 Universal Testing Instrument is used to perform adhesion testing as per Modified Thermal Cycling IPC Test 2.4.9 Method F previously described. The average adhesion values are tabulated below.

## Modified Thermal Cycling Test 2.4.9 Method F

## Adhesion Testing (lb/in)

	Case 1 Microcrack and Bake	Case 2 No Microcrack No Bake
0 Cycle	8.0	6.1
1 Cycle	7.5	0 "blow off"
2 Cycle	7.0	0 "blow off"
3 Cycle	7.2	0 "blow off"

The comparative data and uniform failure modes from Case 1 clearly show the utility of the microcrack and bake process and that the thermal stabilization process is independent of surface texture and Kapton gauge.

\* The term "blow-off" implies catastrophic delamination or blistering at the metal polyimide interface.

## EXAMPLE 12

A 14 inch wide continuous web of type Upilex-S 200 brand polyimide film is treated to render the surface hydrophilic and with a solution formed by mixing 18.5 gallons of a 45% KOH aqueous solution and 6.5 gallons of methanol at 22°C for a dwell time of 110 seconds. The film then was washed extensively with water. The film, as viewed under a microscope, was untextured in that the surface was smooth in appearance. This treated film is further processed as in Example 10 with the exception of step 7 where:

7. A sample of the laminate from step 6 is retained, another is passed through the apparatus of Figure 8, to effect microcracking of the nickel layer, wherein the diameter of roller 16 is 0.103 inches and the gap between rolls 14 and 22 is 0.009 inches.

An Instron Model 1000 Universal Testing Instrument is used to perform adhesion testing as per Modified Thermal Cycling IPC Test 2.4.9 Method F previously described. The average adhesion values are tabulated below.

## Modified Thermal Cycling Test 2.4.9 Method E

## Adhesion Testing (lb/in)

	Case 1 Microcrack and Bake	Case 2 No Microcrack No Bake
0 Cycle	3.2	3.2
1 Cycle	3.0	0 "blow off"
2 Cycle	2.6	0 "blow off"
3 Cycle	2.9	0 "blow off"

The comparative data and uniform failure modes from Case 1 clearly show the utility of the microcrack and bake process and that the thermal stabilization process is independent of surface texture and polyimide type.

\* The term "blow-off" implies catastrophic delamination or blistering at the metal polyimide interface.

## Claims

1. A process for coating at least one surface of a polyimide sheet with copper in the absence of an adhesive, said process comprising hydrophilizing the surface of the polyimide, contacting said sheet with a catalyst to create surfaces receptive to electroless deposition of nickel or cobalt, depositing nickel or cobalt on said receptive surface by electroless deposition of nickel, cobalt, nickel/boron alloy, cobalt/boron alloy or nickel/cobalt/boron alloy to form nickel or cobalt coated surfaces on said sheet, said deposited nickel or cobalt coatings being electrically conductive, forming microcracks in each of said nickel or cobalt coatings, baking said polyimide sheet coated with nickel or cobalt containing microcracks to volatilize components in said polyimide sheet while avoiding delamination of said coatings and depositing copper on said nickel surface of cobalt surface by electrolytic deposition to form exposed copper coatings on said polyimide sheet. 5
2. A process according to Claim 1 wherein said hydrophilization includes treatment with a solution containing an alkali metal hydroxide. 10
3. A process according to Claim 2, comprising contacting said sheet with a one-phase solution of a diamine with the formula  $H_2N(CH_2)_nNH_2$  wherein n is an integer from 2 to 6, an alkali metal hydroxide, a water miscible alcohol and water for a time, and at a temperature sufficient to render the surfaces uniformly and substantially completely textured. 15
4. A process according to Claim 3 wherein said diamine is ethylenediamine. 20
5. A process according to any one of Claims 2, 3 or 4 wherein said alkali metal hydroxide is potassium hydroxide, sodium hydroxide, or a mixture of potassium and sodium hydroxide.
6. A process according to any one of claims 3, 4 or 5, said alcohol is methanol or ethanol.
7. A process according to any one of Claims 1 to 6, comprising electrolytically depositing a thin layer of copper having a thickness less than about  $2.0\ \mu m$  on said nickel or cobalt coating to form dual metal coatings, prior to forming microcracks in each of said nickel or cobalt coatings. 25
8. A process according to Claim 7 wherein the electroless metal coating is coated directly with electrolytically deposited copper without drying between the step of depositing electroless metal and the step of depositing copper. 30
9. A polyimide laminate sheet product including as one layer of said laminate sheet product a polyimide sheet having two surfaces, one or both of said polyimide sheet surfaces being free of an adhesive and having a metal coating comprising an electroless coating of nickel, cobalt, nickel/boron alloy, cobalt/boron alloy or nickel, cobalt/boron alloy, and an electrolytic copper coating bonded to said nickel or cobalt coating(s), said laminate sheet product being capable of passing the Modified Thermal Cycling IPC Test 2.4.9. Method E or F. 35
10. A product according to Claim 9 wherein said electroless coating containing nickel or cobalt is at least  $0.15\ \mu m$  thick.
11. A product according to Claim 9 or 10 wherein the or each of said metal coatings is patterned.
12. A product according to any one of Claims 10, 11, or 12 wherein both polyimide surfaces are coated with metal. 40
13. A product according to any one of Claims 9 to 12; said laminate sheet product having a peel strength of at least  $6.0\ lb./in.$  as measured by IPC Test 2.4.9 Method A and a peel strength of at least  $4.5\ lb./in.$  as measured by IPC Test 2.4.9 Method C and being capable of passing the IPC Test 2.4.13 for solder float and being capable of passing the Modified Thermal Cycling IPC Test 2.4.9 Method E. 45

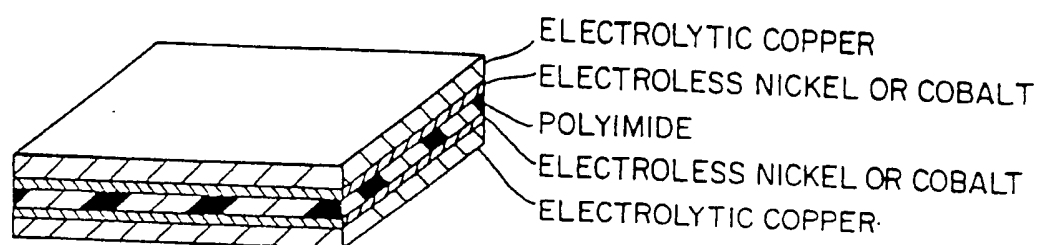
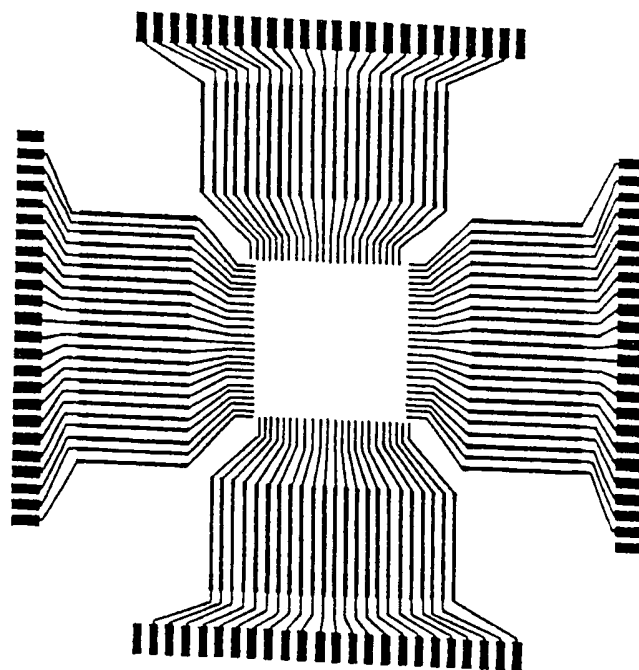
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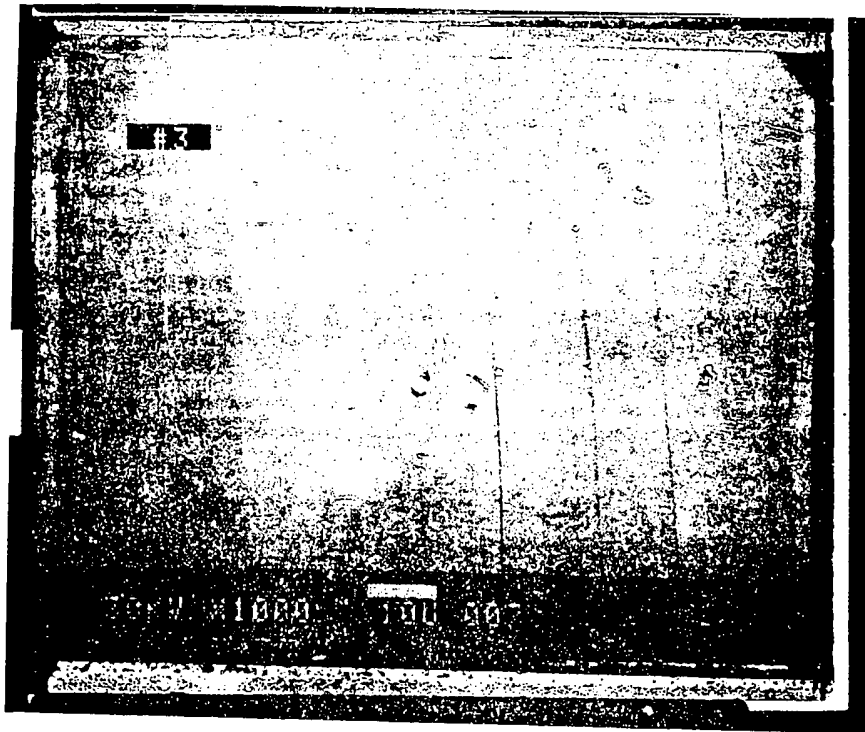
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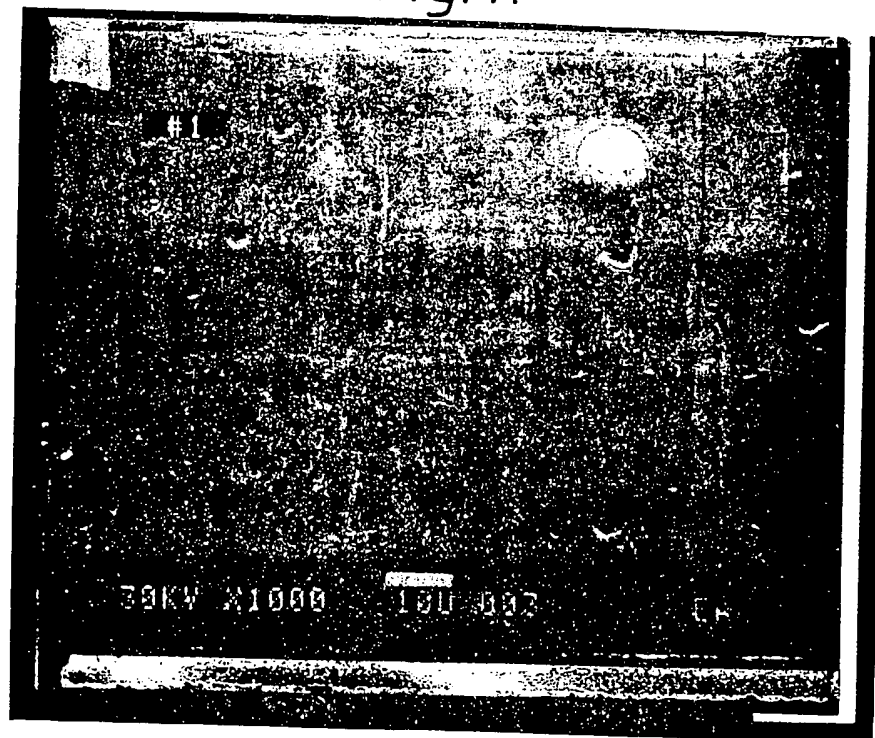
*Fig. 1.**Fig. 2.*

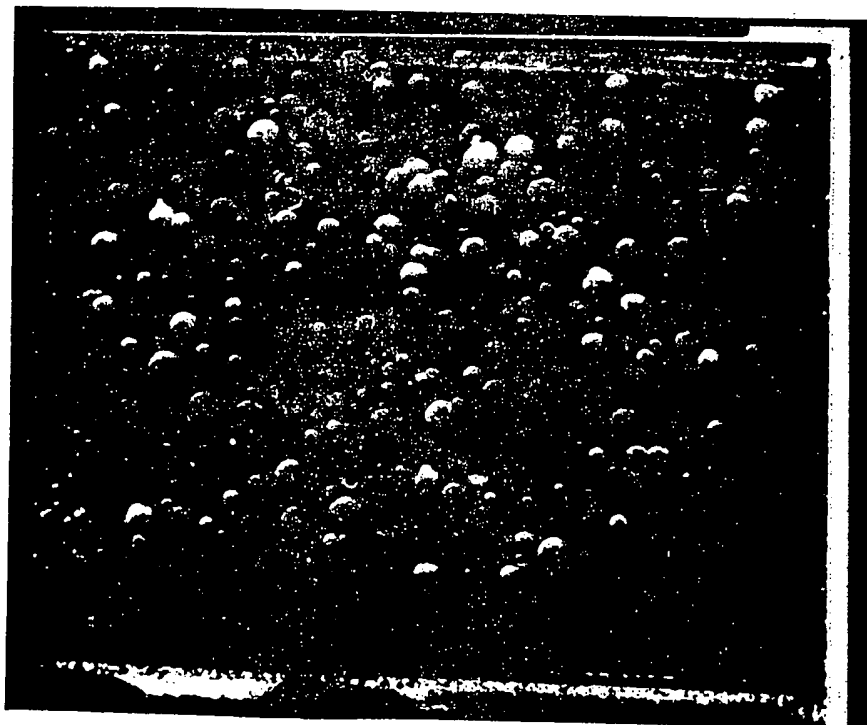
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*Fig.3.*

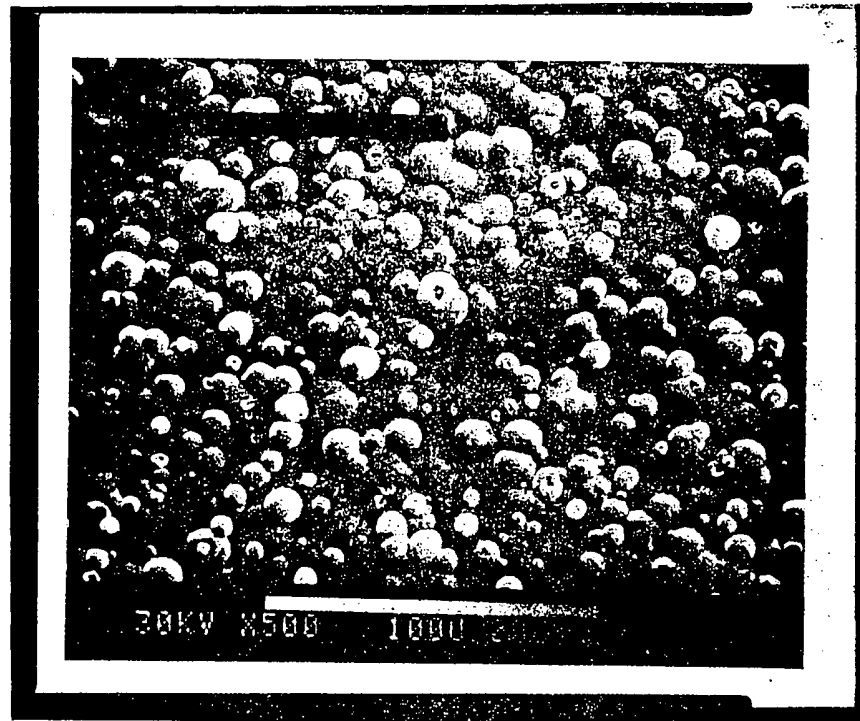
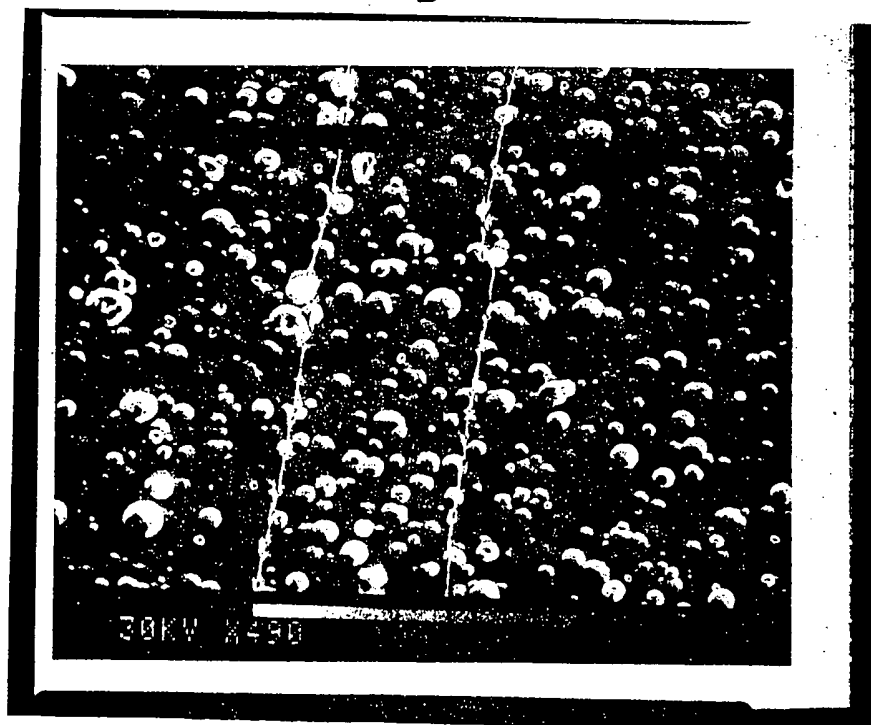


*Fig.4.*



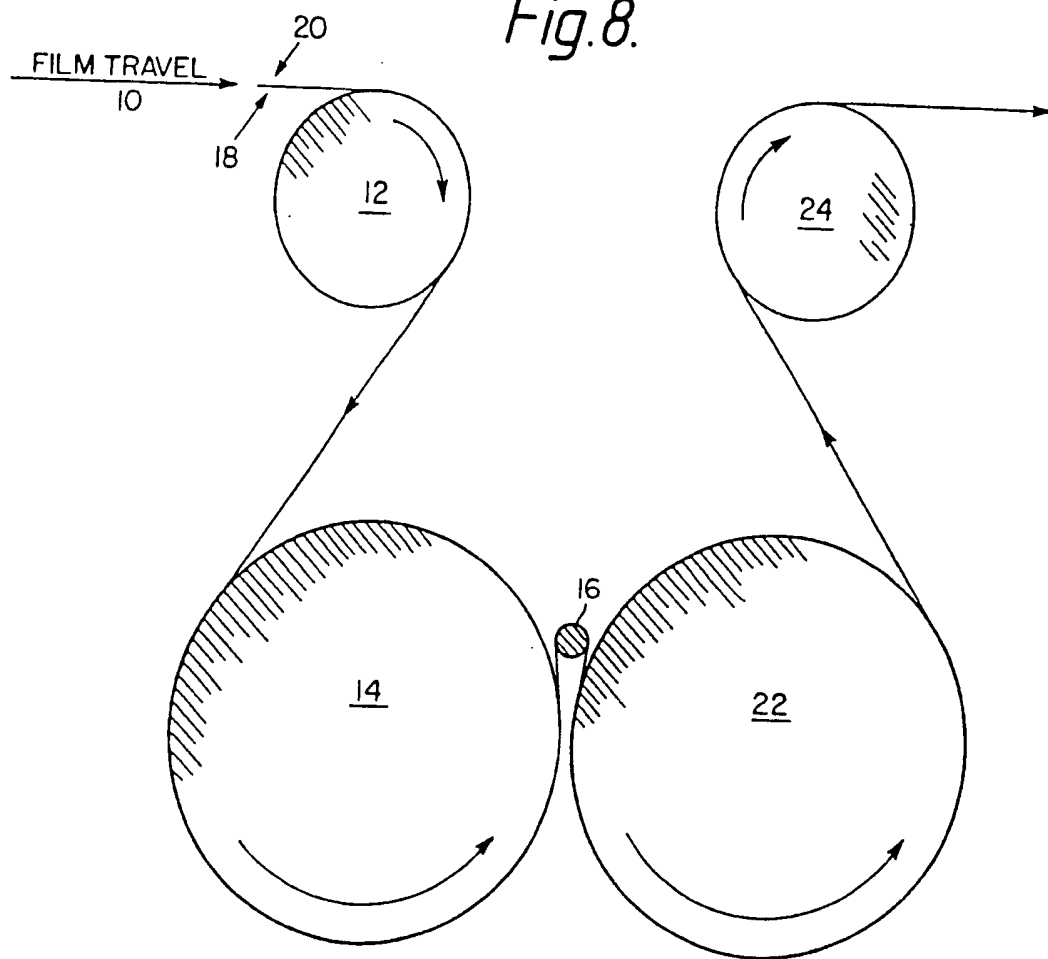
*Fig.5.**Fig.6.*

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*Fig. 7a.**Fig. 7b.*

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Fig. 8.





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Fig. 9.

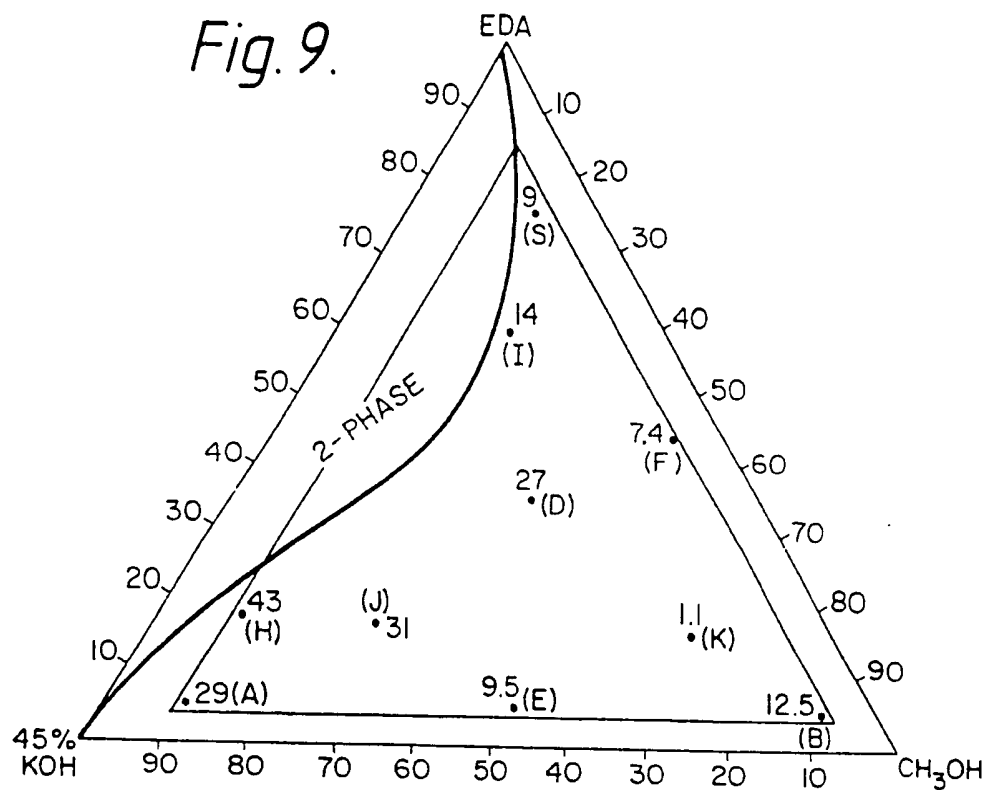
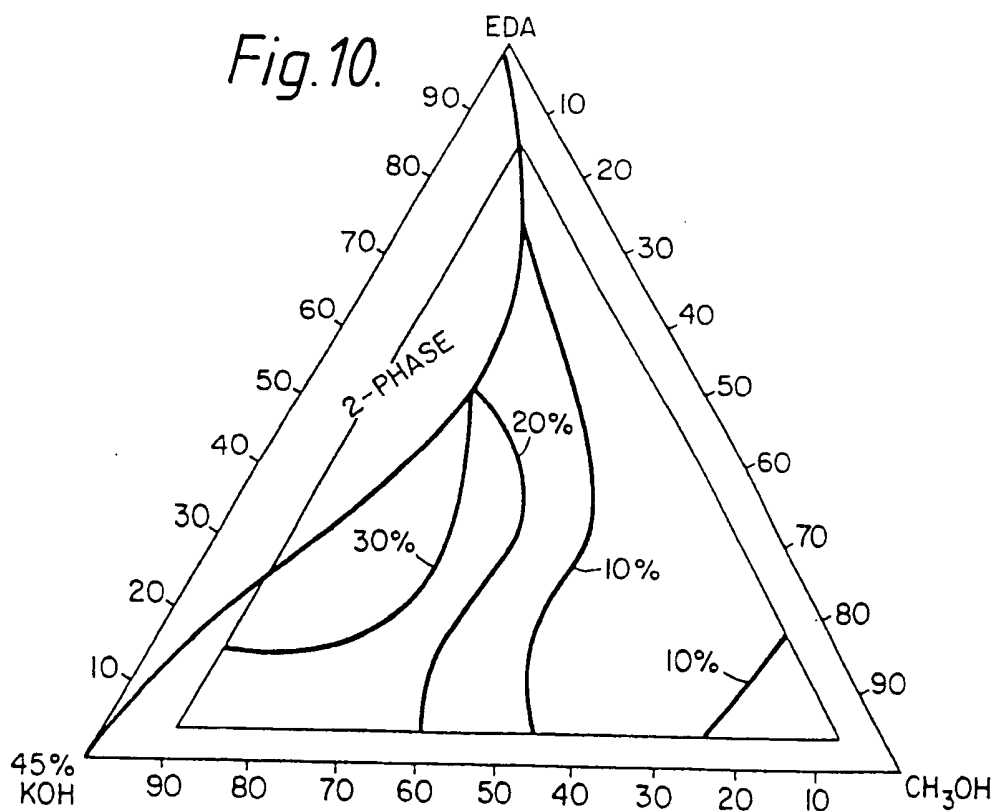


Fig. 10.





DOCUMENTS CONSIDERED TO BE RELEVANT			EP 89301432.4
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int. Cl. 4)
A	US - A - 3 576 723 (W.A.HUNTSVILLE) * Claims 1,2,4; column 4, line 62 - column 5, line 58 * --	1	C 23 C 28/02 B 32 B 15/08
A	DE - A1 - 3 523 669 (M.LADNEY JUN.) * Claim 1 * --	1	
A	US - A - 3 928 148 (L.B.LERNER) * Claim 1; column 1, lines 32-52; column 2, line 36 - column 3, line 5 * --	1	
A	US - A - 4 565 606 (R.CASSAT) * Claims 1-3; column 11, line 56 - column 12, line 2 * ----	1,7	
The present search report has been drawn up for all claims			TECHNICAL FIELDS SEARCHED (Int. Cl. 4)
			C 23 C 28/00 C 23 C 18/00 C 25 D 5/00 B 32 B
Place of search VIENNA		Date of completion of the search 10-05-1989	Examiner DUNGLER
CATEGORY OF CITED DOCUMENTS			
X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document		T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons & : member of the same patent family, corresponding document	